## The model of form error



In summary, in manufacturing processes two kinds of deviations are obtained:

- (a) low-frequency waviness deviations, often caused by loss of centricity in the spindle of tools or parts;
- (b) high-frequency waviness deviation (similar to a noisy error), often linked to a vibration in the cutting process or improper setting of the cutting parameters.

Thus a roundness deviation assumes a waviness form with a random perturbation superimposed (Fig. 1). Based upon the major influence of the two different kinds of manufacturing errors, the deviation appears to be more wavy and less random within a given range of error and vice versa.

Parametric model and distribution diagram of roundness deviation in accordance with least-squares substitute geometry. Angle coordinates are expressed in  $2\pi/90$  radians

#### Development of a classifier cyclic/noisy deviations



Distribution diagram versus percentage of wave amplitude within roundness error amplitude

## Clustering Algorithm



Fig. 3 Lobe-filtering system of a pure sinusoid deviation

Fig. 4 Process of roundness error evaluation with the proposed system

# Lobe Filtering



#### Exponential distribution with initial point  $\gamma$

$$
D(\gamma, i) = \gamma + (\pi \cdot i^{-1})/2, \quad i = 2, ..., n_2
$$
 (5)

This distribution is exponential because the distance between the starting point and the  $i<sup>n</sup>$  location decreases in accordance with  $I^1$  (i.e. the period of the Fourier series). If z<sub>i</sub> denotes the measurements at the locations

#### Modello di rumore

*E* max rumore,  $f \in [0,1]$ 

 $y_i - y_{i,1} \le f \cdot E, \quad i = 3, ..., n_2 + 2$  $(7)$ 

where  $f \in E$  is a non-negligible percentage of roundness error  $[5]$ .

#### Modified IPR for noisy filtering

As the IPR gives a prediction based on past data, this algorithm can be used to smooth the noise by means of a linear combination between the predicted value  $Y_i$  and the obtained measurement  $y_i$ , like the following:

$$
y'_{i} = \alpha Y_{i} + (1 - \alpha) y_{i}, i = s, ..., n_{2} + 2, \alpha \in [0, 1]
$$
 (8)



## The Minimum Zone Roundness problem (MZR)

• Find a point (x, y) such that the distance between the blue line and the pink line is minimal (the minimal circular ring enclosing the cloud).



## Deviations type



Fig. 3. Roundness deviations of samples no. 2-7 of Table 2 with the reference circles in Fig. 1.





#### Genetic algorithms for the MZT

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#### **Table 1**

Genetic operators, their parameters and mechanisms.



Fig. 2. Standard GA scheme.

# GA time reduction

- 1. reduction of population, *pop*
- 2. reduction of crossover prob., *pc*
- 3. stop the algorithm as earlier as possible, *N*
- 4. Concentrate the population, *E*

# Reduction of the population (*pop*)

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Fig. 5. GA parameters exploration: target roundness error  $R^*$  on dataset no. 1 of Table 2 as a function of pc and pm for two different values of pop upon an area of promising configuration (from Fig. 4) of pc and pm.

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#### Combined optimization of parametes *pc* e *pm*



Fig. 6. GA parameters optimization: average computation time on the samples of Table 2 as a function of pc and pm for four different values of pop and convergence of the average roundness error for the selected parameters (left inset).

## Computation time by GA



Fig. 7. Convergence of MZT for the seven samples of Table 2 with the selected values of the optimal parameters in Table 4.